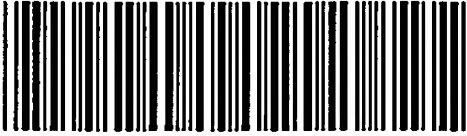


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| <div>Search Notes</div> <div></div> | Application/Control No. | Applicant(s)/Patent under Reexamination |  |
|  | 10/692,537              | KLUWE, LAN                              |  |
|  | Examiner                | Art Unit                                |  |
|  | Young J. Kim            | 1637                                    |  |

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| SEARCH NOTES<br>(INCLUDING SEARCH STRATEGY)   |           |      |
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|   | DATE      | EXMR |
| Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)<br>see enclosed for text-search strategy | 8/11/2006 | YJK  |
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